

Notice of References Cited

Application/Control No.

10/758,486

Applicant(s)/Patent Under
Reexamination
ABDO ET AL.

Examiner

GIOVANNA COLAN

Art Unit

2162

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,785,677	08-2004	Fritchman, Barry Lynn	707/6
*	B	US-2002/0198867	12-2002	Lohman et al.	707/3
	C	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Haas et al. (NPL: "Sampling - Based Selectivity for joins Using Augmented Frequent Value Statistics", Peter J. Haas, Arun N. Swami, IBM Almaden Research Center, San Jose CA, 1995, IEEE)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.